

Notice of References Cited

Application/Control No.

10/520,618

Applicant(s)/Patent Under
Reexamination
AOKI ET AL.

Examiner

Edu E. Enin-Okut

Art Unit

4132

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,727,014	04-2004	Wilson et al.	429/26
	B	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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